SCLS325B - MARCH 1996 - REVISED MAY 1997

- C **High Degree of Linearity** Ε **High On-Off Output Voltage Ratio** Low Crosstalk Between Switches Low On-State Impedance — Typically, 50 Ω at V_{CC} = 6 V • **Individual Switch Controls Extremely Low Input Current Package Options Include Plastic**
- Small-Outline (D), Plastic Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, and Standard Plastic (N) 300-mil DIPs

D, DB, I		or M P VI		KAGE
4 4 1	ſ.	υ		
1A	1		14	VCC
1B [2		13	V _{CC} 1C
2B [3		12	4C
2A [4		11	4A
2C [5		10	4B
3C [6		9	3B
GND [7		8	ЗA

description

logic symbol[†]

The SN74HC4066 is a silicon-gate CMOS quadruple analog switch designed to handle both analog and digital signals. Each switch permits signals with amplitudes of up to 6 V (peak) to be transmitted in either direction.

Each switch section has its own enable input control (C). A high-level voltage applied to C turns on the associated switch section.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

The SN74HC4066 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each switch)						
INPUT CONTROL (C)	SWITCH					
L	OFF					
Н	ON					



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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SCLS325B - MARCH 1996 - REVISED MAY 1997

logic diagram, each switch (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} (see Note 1)		–0.5 V to 7 V
Control-input diode current, I_I ($V_I < 0$ or $V_I > V_G$	сс)	±20 mA
I/O port diode current, I _I (V _I < 0 or V _{I/O} < V _{CC}))	±20 mA
On-state switch current ($V_{I/O} = 0$ to V_{CC})		±25 mA
Continuous current through V _{CC} or GND		±50 mA
Package thermal impedance, θ_{JA} (see Note 2)): D package	127°C/W
	DB package	158°C/W
	N package	
	PW package	170°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to ground unless otherwise specified.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



SCLS325B - MARCH 1996 - REVISED MAY 1997

recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	V _{CC} Supply voltage					V
V _{I/O}	I/O port voltage		0		VCC	V
	V _{CC} = 2 \		1.5		VCC	
ViH		$V_{CC} = 4.5 V$	3.15		VCC	V
		$V_{CC} = 6 V$	4.2		VCC	
		$V_{CC} = 2 V$	0		0.3	v
VIL		$V_{CC} = 4.5 V$	0		0.9	
		VCC = 6 V	0		1.2	
		$V_{CC} = 2 V$			1000	
tt	Input rise/fall time	$V_{CC} = 4.5 V$			500	ns
		Λ CC = 6 Λ			400	
ТĄ	Operating free-air temperature		-40		85	°C

[†] With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A = 25°C				LINUT	
			TEST CONDITIONS V		MIN	TYP	MAX	MIN MAX	UNIT
R _{on} On-state switch resistance					150				
		e	$I_T = -1 \text{ mA}, V_I = 0 \text{ to } V_{CC},$ $V_C = V_{IH}, \text{ (see Figure 1)}$	4.5 V		50	85	106	Ω
				6 V		30			
			2 V		320				
R _{on(p)}	Peak on resistance		$V_I = V_{CC}$ or GND, $V_C = V_{IH}$, $I_T = -1$ mA	4.5 V		70	170	215	Ω
				6 V		50			
Ц	Control input current		$V_{C} = 0 \text{ or } V_{CC}$	6 V		±0.1	±100	±1000	nA
I _{soff}	Off-state switch leakage c	urrent	$V_I = V_{CC}$ or 0, $V_O = V_{CC}$ or 0, $V_C = V_{IL}$, (see Figure 2)	6 V			±0.1	±5	μA
I _{son}	On-state switch leakage c	urrent	$V_I = V_{CC}$ or 0, $V_C = V_{IH}$, (see Figure 3)	6 V			±0.1	±5	μΑ
ICC	Supply current		$V_{I} = 0 \text{ or } V_{CC}, \qquad I_{O} = 0$	6 V			2	20	μΑ
0		A or B		5 V					рF
Ci	Input capacitance	С		5 V		3	10	10	рг
Cf	Feedthrough capacitance	A to B	$V_{I} = 0$			0.5			pF
Co	Output capacitance	A or B		5 V		9			pF



SCLS325B - MARCH 1996 - REVISED MAY 1997

switching characteristics over recommended operating free-air temperature range

PARAM	RAMETER	FROM	то	TEST	Vee	Тд	(= 25°C	;	MIN	МАХ	UNIT				
FA	RAMETER	(INPUT)	(OUTPUT)	CONDITIONS	Vcc	MIN	TYP	MAX		IVIAA	UNIT				
			2 V		10	60		75							
^t PLH, ^t PHL	Propagation delay time	A or B	B or A	$C_L = 50 \text{ pF},$ (see Figure 4)	4.5 V		4	12		15	ns				
ΥΠL				(See Figure T)	6 V		3	10		13					
	$R_{\rm L} = 1 \rm k\Omega$,	2 V		70	180		225								
^t PZH [,] tPZL	Switch turn-on time	С	A or B	CL = 50 pF, 4 (see Figure 5)	4.5 V		21	36		45	ns				
ΥZL					6 V		18	31		38					
	Switch turn-off time	С		RL = 1 kΩ, CL = 50 pF,	2 V		50	200		250	ns				
^t PLZ, tPHZ			A or B CL		4.5 V		25	40		50					
ΥΠΖ					(see Figure 5)	6 V		22	34		43				
	Control			$C_{L} = 15 \text{ pF},$ $R_{I} = 1 \text{ k}\Omega,$	2 V		15								
fı	input	С	A or B		A or B	A or B	A or B	A or B $V_{C}^{-} = V_{CC}$ or GND,	4.5 V		30				MHz
	frequency					6 V		30							
	Control feedthrough		A or B	$R_{in} = R_{L} = 600 \Omega_{2}$	4.5 V		15				mV				
	noise	С	AUR	$V_C = V_{CC}$ or GND, $f_{in} = 1$ MHz, (see Figure 7)	6 V		20				(rms)				

operating characteristics, V_{CC} = 4.5 V, T_A = 25°C

	PARAMETER	TEST C	TYP	UNIT	
Cpd	Power dissipation capacitance per gate	C _L = 50 pF,	f = 1 MHz	45	pF
	Minimum through bandwidth, A to B or B to A [†] [20 log (V _O /V _I)] = -3 dB	$C_L = 50 \text{ pF},$ $V_C = V_{CC},$	RL = 600 Ω, (see Figure 8)	30	MHz
	Crosstalk between any switches‡	C _L = 10 pF, f _{in} = 1 MHz,	$R_L = 50 \Omega$, (see Figure 9)	45	dB
	Feedthrough, switch off, A to B or B to A^{\ddagger}	C _L = 50 pF, f _{in} = 1 MHz,	R _L = 600 Ω, (see Figure 10)	42	dB
	Amplitude distortion rate, A to B or B to A	C _L = 50 pF, f _{in} = 1 kHz,	$R_L = 10 k\Omega$, (see Figure 11)	0.05%	

[†] Adjust the input amplitude for output = 0 dBm at f = 10 kHz. Input signal must be a sine wave.

‡ Adjust the input amplitude for output = 0 dBm at f = 1 MHz. Input signal must be a sine wave.



SCLS325B - MARCH 1996 - REVISED MAY 1997

PARAMETER MEASUREMENT INFORMATION













SCLS325B - MARCH 1996 - REVISED MAY 1997









Figure 4. Propagation Delay Time, Signal Input to Signal Output



SCLS325B - MARCH 1996 - REVISED MAY 1997



PARAMETER MEASUREMENT INFORMATION

Figure 5. Switching Time (t_{PZL} , t_{PLZ} , t_{PZH} , t_{PHZ}), Control to Signal Output



SCLS325B - MARCH 1996 - REVISED MAY 1997

PARAMETER MEASUREMENT INFORMATION



Figure 6. Control Input Frequency



Figure 7. Control Feedthrough Noise



Figure 8. Minimum Through Bandwidth



SCLS325B - MARCH 1996 - REVISED MAY 1997









Figure 10. Feedthrough, Switch Off



Figure 11. Amplitude Distortion Rate



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